

Pb RoHS

#### **General Description**

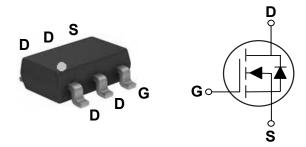
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	Ι <sub>D</sub>
30 V	24 mΩ	6.5 A

#### Features

- $R_{DS(ON)} \leq 24m\Omega @V_{GS} = 10V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

#### SOT-23-6 Pin Configuration



Absolute Maximum Patings T =25°C unloss otherwise noted

#### **Applications**

- MB / VGA / Vcore
- Load Switch
- Hand-Held Instrument

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	30	V
V <sub>GS</sub>	Gate-Source Voltage	±20	V
I	Drain Current - Continuous (T <sub>C</sub> =25°C)	6.5	Α
Ι <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> =100°C)	4.1	А
I <sub>DM</sub>	Drain Current - Pulsed (NOTE 1)	26	А
EAS	Single Pulse Avalanche Energy (NOTE 2)	32	mJ
IAS	Single Pulse Avalanched Current (NOTE 2)	8	А
P <sub>D</sub>	Power Dissipation (T <sub>C</sub> =25°C)	1.56	W
I D	Power Dissipation - Derate above 25°C	0.012	W/°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
Marking Code		V	

Thermal Characteristics					
Symbol	Parameter	Тур.	Max.	Unit	
$R_{ extsf{ heta}JA}$	Thermal Resistance Junction to Ambient		80	°C/W	





#### Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	30			V
I <sub>DSS</sub> Drain-Source Leak	Drain Source Lookage Current	$V_{DS}$ =30V , $V_{GS}$ =0V , $T_{J}$ =25°C			1	uA
	Dialit-Source Leakage Current	$V_{DS}$ =24V , $V_{GS}$ =0V , $T_{J}$ =125°C			10	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ =±20V , $V_{DS}$ =0V			±100	nA

#### **On Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =6A			24	mΩ
		V <sub>GS</sub> =4.5V , I <sub>D</sub> =4A			34	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1.2	1.6	2.5	V
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =4A		6.5		S

#### **Dynamic and switching Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$Q_g$	Total Gate Charge	V <sub>DS</sub> =15V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =6A (NOTE 3 ` 4)		4.1		
$Q_gs$	Gate-Source Charge			1.0		nC
$Q_{gd}$	Gate-Drain Charge			2.1		
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> =15V , V <sub>GS</sub> =10V , R <sub>G</sub> =6Ω , I <sub>D</sub> =1A (NOTE 3 \ 4)		2.8		
Tr	Rise Time			7.2		nS
T <sub>d(off)</sub>	Turn-Off Delay Time			15.8		115
T <sub>f</sub>	Fall Time			4.6		
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =25V , V <sub>GS</sub> =0V , F=1MHz		345		
C <sub>oss</sub>	Output Capacitance			55		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			32		
$R_{g}$	Gate resistance	$V_{GS}$ =0V , $V_{DS}$ =0V , F=1MHz		3.2		Ω

#### **Drain-Source Diode Characteristics and Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I <sub>S</sub>	Continuous Source Current	$V_{G}=V_{D}=0V$ , Force Current			6.5	А
I <sub>SM</sub>	Pulsed Source Current				26	А
$V_{SD}$	Diode Forward Voltage	$V_{GS}$ =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25 <sup>o</sup> C			1	V

NOTES :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.

2.  $V_{DD}$ =25V,  $V_{GS}$ =10V, L=1mH, I<sub>AS</sub>=8A, R<sub>G</sub>=25 $\Omega$ , Starting T<sub>J</sub>=25 $^{\circ}$ C.

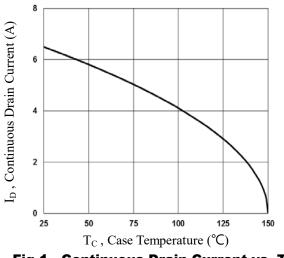
3. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.

4. Essentially independent of operating temperature.

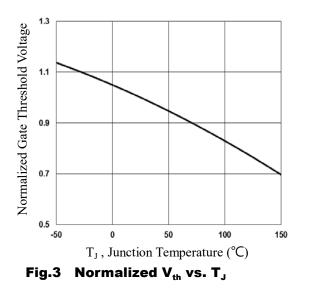


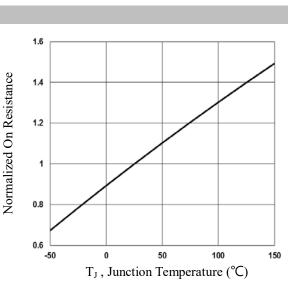
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#### **Characteristics Curves**











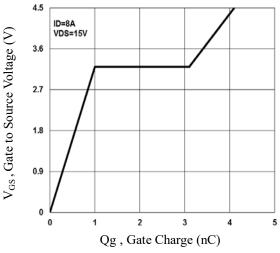
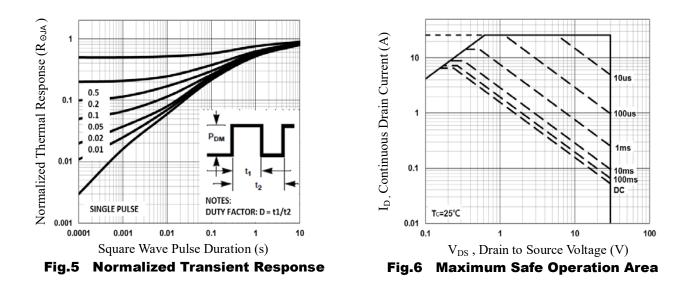


Fig.4 Gate Charge Waveform





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### **30V N-Channel MOSFETs**

#### **Characteristics Curves**

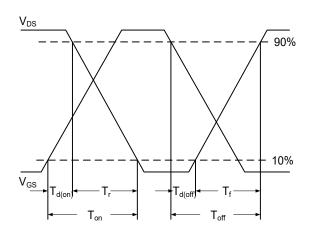
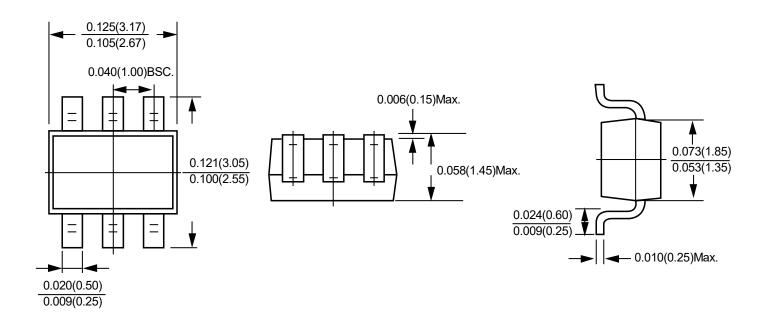


Fig.7 Switching Time Waveform

#### Package Outline Dimensions



### SOT-23-6

Dimensions in inches and (millimeters)



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